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BLX95

U.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor intended for transmitting applications in class-A, B or C in the u.h.f. frequency range for supply voltages up to 28 V. The transistor is resistance stabilized and is tested under severe load mismatch conditions. Due to a gold metallization excellent reliability properties have been obtained. The transistor is housed in a capstan envelope with a moulded cap. All leads are isolated from the stud.

QUICK REFERENCE DATA

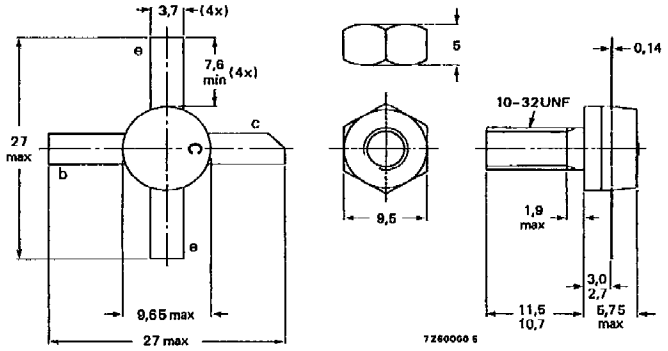
R.F. performance up to T_h = 25 °C in an unneutralized common-emitter class-B circuit

mode of operation	V_{CE} V	f MHz	P_S W	P_L W	I_C A	G_p dB	η %
c.w.	28	470	< 14,2	40	< 2,4	> 4,5	> 60
c.w.	28	175	typ. 3,2	40	typ. 1,9	typ. 11	typ. 75

MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-56.



Torque on nut: min. 1,5 Nm (15 kg cm)
max. 1,7 Nm (17 kg cm)

Diameter of clearance hole in heatsink: max. 4,9 mm.
Mounting hole to have no burrs at either end.
De-burring must leave surface flat; do not chamfer or countersink either end of hole.

When locking is required an adhesive is preferred instead of a lock washer.

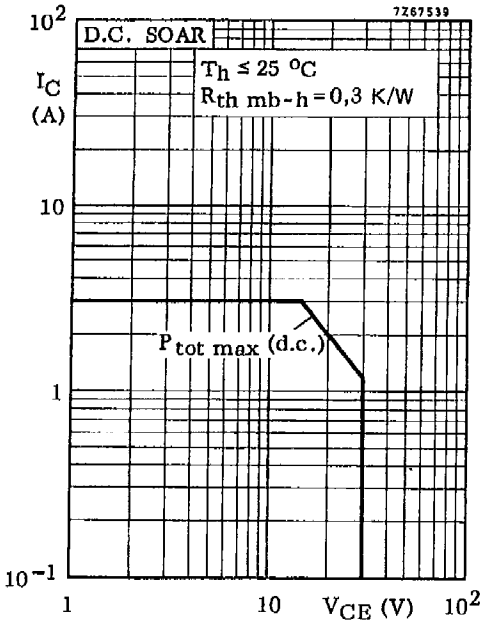
PRODUCT SAFETY This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

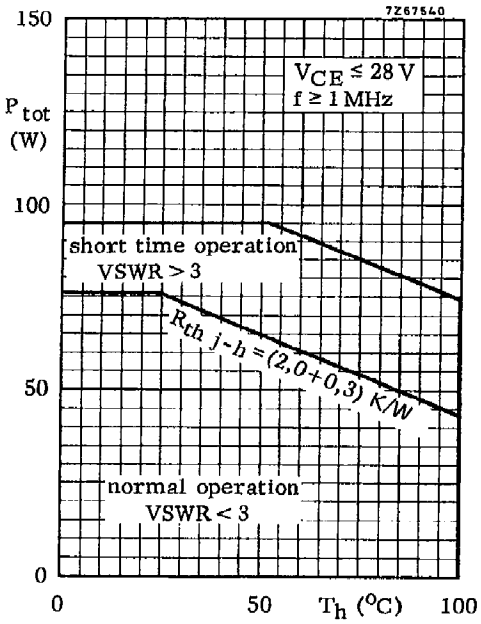
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Quality Semi-Conductors

RATINGS Limiting values in accordance with the Absolute Maximum System

Collector-base voltage (open emitter) peak value	V_{CBOM}	max.	65	V
Collector-emitter voltage ($R_{BE} = 10\,\Omega$) peak value	V_{CERM}	max.	65	V
Collector-emitter voltage (open base)	V_{CEO}	max.	30	V
Emitter-base voltage (open collector)	V_{EBO}	max.	4	V
Collector current (average)	$I_{C(AV)}$	max.	3,0	A
Collector current (peak value) f > 1 MHz	I_{CM}	max.	10,0	A





Storage temperature	T_{stg}		−65 to +200	°C
Junction temperature	T_j	max.	200	°C

THERMAL RESISTANCE

From junction to mounting base	$R_{th\ j\text{-}mb}$	=	2,0	K/W
From mounting base to heatsink	$R_{th\ mb\text{-}h}$	=	0,3	K/W

CHARACTERISTICS

T_j = 25 °C unless otherwise specified

Breakdown voltages				
Collector-base voltage open emitter, I_C = 50 mA	$V_{(BR)CBO}$	>	65	V
Collector-emitter voltage R_{BE} = 10Ω, I_C = 50 mA	$V_{(BR)CER}$	>	65	V
Collector-emitter voltage open base, I_C = 50 mA	$V_{(BR)CEO}$	>	30	V
Emitter-base voltage open collector, I_E = 10 mA	$V_{(BR)EBO}$	>	4	V
Transient energy				
L = 25 mH; f = 50 Hz				
open base	E	>	4,5	mS
$-V_{BE}$ = 1,5 V; R_{BE} = 33 Ω	E	>	4,5	mS
D.C. current gain				
I_C = 1,0 A; V_{CE} = 5 V	h_{FE}	25 to 100		
Transition frequency				
I_C = 4 A; V_{CE} = 25 V	f_T	typ.	900	MHz
Collector capacitance at f = 1 MHz				
$I_E = I_e$ = 0; V_{CB} = 30 V	C_c	typ.	68	pF
		<	80	pF
Feedback capacitance at f = 1 MHz				
I_C = 200 mA; V_{CE} = 30 V	C_{re}	typ.	39	pF
Collector-stud capacitance	C_{cs}	typ.	2	pF